

Search Notes

Application/Control No.

10/759,419

Examiner

John P. Sheehan

Applicant(s)/Patent under
Reexamination

IRIYAMA ET AL.

Art Unit

1742

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	9/26/2005	JS